Rev.2.0

 Fast recovery 	
 Soft switching 	

• Low reverse recovery charge

• 1200 V EmCon technology

Fast Switching EmCon Diode

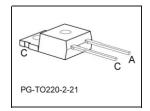
- Low forward voltage
- Easy paralleling

Feature

- Pb-free lead plating; RoHS compliant
- Qualified according to JEDEC⁽⁰⁾ for target applications

Product Summarv

T Todaot Gainnary				
V _{RRM}	1200	V		
/ _F	30	А		
V _F	1.65	V		
T _{jmax}	150	°C		



Туре	Package	Marking	Pin 1	PIN 2	PIN 3
IDH30E120	PG-TO220-2-21	D30E120	С	А	-

Maximum Ratings, at $T_i = 25 \text{ °C}$, unless otherwise specified

Parameter	Symbol	Value	Unit
Repetitive peak reverse voltage	V _{RRM}	1200	V
Continous forward current	/ _F		Α
<i>T</i> _C =25°C		50	
<i>T</i> _C =90°C		30	
Surge non repetitive forward current	/ _{FSM}	102	
7 _C =25°C, t _p =10 ms, sine halfwave			
Maximum repetitive forward current	/ _{FRM}	76.5	
T _C =25°C, <i>t</i> _p limited by <i>T</i> _{jmax} , <i>D</i> =0.5			
Power dissipation	P _{tot}		W
<i>T</i> _C =25°C		138	
<i>T</i> _C =90°C		66	
Operating and storage temperature	T _j , T _{stg}	-55+150	°C
Soldering temperature	T _S	260	°C
wavesoldering, 1.6mm (0.063 in.) from case for 10s			

⁰ J-STD20 and JESD22

IDH30E120





Thermal Characteristics

Parameter	Symbol	Symbol Values		Unit	
		min.	typ.	max.	
Characteristics					
Thermal resistance, junction - case	R _{thJC}	-	-	0.9	K/W
Thermal resistance, junction - ambient, leaded	R _{thJA}	-	-	62	

Parameter	Symbol	Values		Unit	
		min.	typ.	max.	
Static Characteristics					-
Reverse leakage current	/ _R				μA
V _R =1200V, <i>T</i> _j =25°C		-	-	100	
V _R =1200V, <i>T</i> _j =150°C		-	-	2500	
Forward voltage drop	V _F				V
/ _F =30A, <i>T</i> j=25°C		-	1.65	2.15	
/ _F =30A, <i>T</i> _j =25°C / _F =30A, <i>T</i> _j =150°C		_	1.7	-	

Electrical Characteristics, at T_i = 25 °C, unless otherwise specified

¹Device on 40mm*40mm*1.5mm epoxy PCB FR4 with 6cm² (one layer, 70 µm thick) copper area for drain connection. PCB is vertical without blown air.



Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Dynamic Characteristics					
Reverse recovery time	t _{rr}				ns
V _R =800V, <i>I</i> _F =30A, d <i>i</i> _F /d <i>t</i> =850A/μs, <i>T</i> _j =25°C		-	243	-	
V _R =800V, <i>I</i> _F =30A, d <i>i</i> _F /d <i>t</i> =850A/μs, <i>T</i> _j =125°C		-	355	-	
V _R =800V, <i>I</i> _F =30A, d <i>i</i> _F /d <i>t</i> =850A/μs, <i>T</i> _j =150°C		-	380	-	
Peak reverse current	/ _{rrm}				А
V _R =800V, <i>I</i> _F = 30 A, d <i>i</i> _F /d <i>t</i> =850A/µs, <i>T</i> _j =25°C		-	23.7	-	
V _R =800V, <i>I</i> _F =30A, d <i>i</i> _F /d <i>t</i> =850A/µs, <i>T</i> _j =125°C		-	28.3	-	
$V_{\rm R}$ =800V, $I_{\rm F}$ =30A, $di_{\rm F}/dt$ =850A/µs, $T_{\rm j}$ =150°C		-	29.5	-	
Reverse recovery charge	Q _{rr}				nC
V _R =800V, <i>I</i> _F =30A, d <i>i</i> _F /d <i>t</i> =850A/μs, <i>T</i> _j =25°C		-	2630	-	
V _R =800V, I _F =30A, d <i>i</i> _F /d <i>t</i> =850A/μs, <i>T</i> _j =125°C		-	4700	-	
V _R =800V, I _F =30A, d <i>i</i> _F /d <i>t</i> =850A/µs, <i>T</i> j=150°C		-	5200	-	
Reverse recovery softness factor	S				
V _R =800V, / _F =30A, d <i>i</i> _F /d <i>t</i> =850A/μs, <i>T</i> j=25°C		-	6	-	
V _R =800V, I _F =30A, d <i>i</i> _F /d <i>t</i> =850A/μs, <i>T</i> _j =125°C		_	7.4	-	
V _R =800V, <i>I_F</i> =30A, d <i>i_F</i> /d <i>t</i> =850A/µs, <i>T</i> _j =150°C		-	7.5	-	

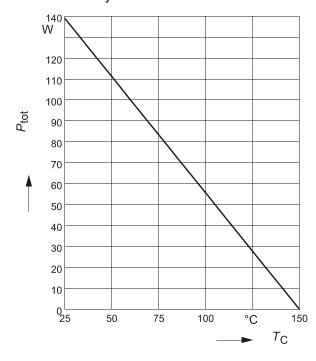
Electrical Characteristics, at $T_i = 25$ °C, unless otherwise specified



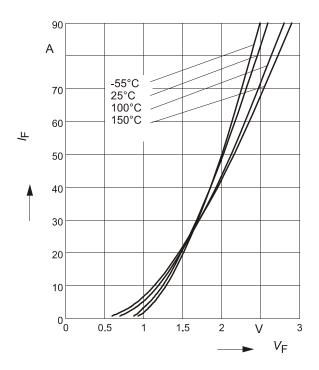
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1 Power dissipation

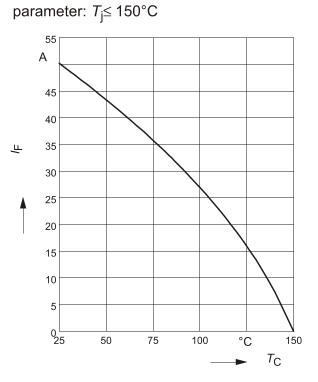
 $P_{\text{tot}} = f(T_{\text{C}})$ parameter: T_j ≤ 150°C





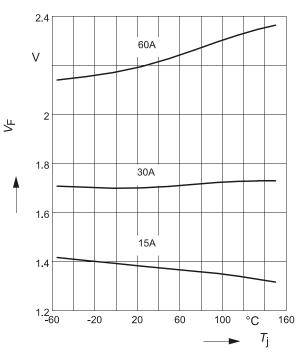


2 Diode forward current $I_{\rm F} = f(T_{\rm C})$



4 Typ. diode forward voltage

 $V_{\mathsf{F}} = f(T_{\mathsf{j}})$



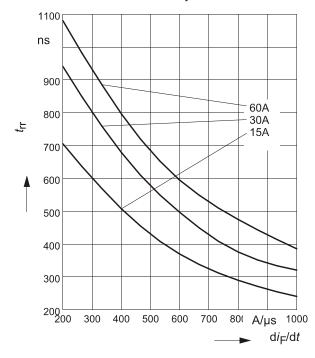
2007-02-26



5 Typ. reverse recovery time

 $t_{\rm rr} = f \left({\rm d}i_{\rm F}/{\rm d}t \right)$

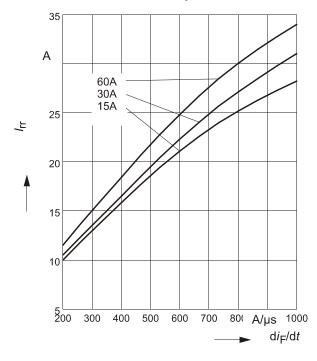
parameter: V_R = 800V, T_j = 125°C



7 Typ. reverse recovery current

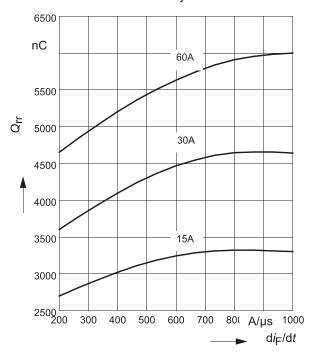
 $I_{\rm rr} = f \left({\rm d}i_{\rm F} / {\rm d}t \right)$

parameter: V_R = 800V, T_i = 125°C



6 Typ. reverse recovery charge Q_{rr}=f(d*i*_F/d*t*)

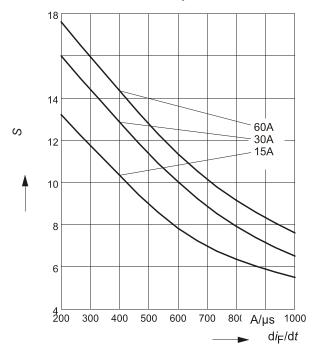
parameter: V_R = 800V, T_i = 125 °C



8 Typ. reverse recovery softness factor

 $S = f(di_F/dt)$

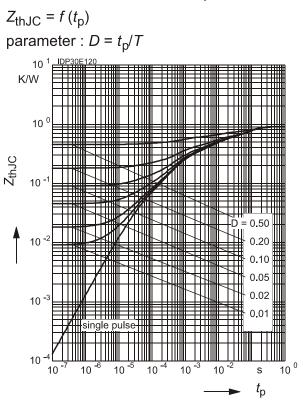
parameter: V_{R} = 800V, T_{i} = 125°C



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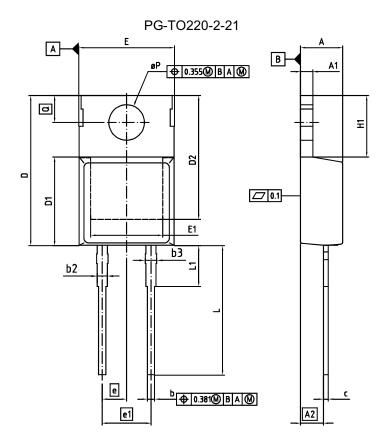


9 Max. transient thermal impedance



IDH30E120





	dimensions			
symbol	[mm]		[inch]	
-	min	max	min	max
А	4.191	4.699	0.165	0.185
A1	1.219	1.321	0.048	0.052
A2	2.387	2.489	0.094	0.098
b	0.635	0.889	0.025	0.035
b2	1.143	1.397	0.045	0.055
b3	1.143	1.651	0.045	0.065
С	0.331	0.635	0.013	0.025
D	15.113	15.621	0.595	0.615
D1	9.017	9.271	0.355	0.365
D2	13.737	14.245	0.541	0.561
E	9.677	9.931	0.381	0.391
E1	8.28	8.788	0.324	0.346
е	2.54		0.1	
e1	5.029	5.131	0.198	0.202
H1	6.096	6.35	0.24	0.25
L	12.802	13.31	0.504	0.524
L1	3.048	3.302	0.12	0.13
P	3.632	3.734	0.143	0.147
Q	2.54	3.048	0.1	0.12



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